

Search Notes

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Examiner

Hai L. Nguyen

Applicant(s)/Patent under
Reexamination

JOHNSON ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
327	2,3,7,12	5/24/2005	HLN
	39-43,47		
	49,162		
	163		
331	25,DIG.2		
Update	Search	9/30/2005	HLN
327	5	9/30/2005	HLN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See	Printout	10/2/2005	HLN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR